

Notice of References Cited

Application/Control No.

09/938,145

Applicant(s)/Patent Under
Reexamination
TAKAHASHI ET AL.

Examiner

Jason Proctor

Art Unit

2123

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0085311 A1	05-2004	Lee et al.	345/419
*	B	US-5,864,777 A	01-1999	Smith et al.	702/156
*	C	US-6,654,654 B1	11-2003	Subrahmanyam et al.	700/98
*	D	US-6,304,794 B1	10-2001	Nishimine et al.	700/197
*	E	US-5,717,905 A	02-1998	Iwamoto et al.	703/1
*	F	US-6,219,055 B1	04-2001	Bhargava et al.	345/850
*	G	US-5,859,786 A	01-1999	Klein, Rudiger	703/2
*	H	US-6,788,984 B2	09-2004	Plotkin, Jon K.	700/97
*	I	US-4,736,306	04-1988	Christensen et al.	345/420
*	J	US-2003/0061014 A1	03-2003	Cheng et al.	703/2
*	K	US-6,120,171 A	09-2000	Shaikh, Mohammad Salim	700/98
*	L	US-5,253,336 A	10-1993	Yamada, Keiichi	345/442
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.